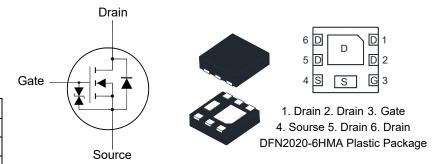
## **N-Channel Enhancement Mode MOSFET**

#### **Features**

- Surface-mounted package
- Built-in G-S Protection Diode
- Typical ESD Protection HBM Class 2

Classification	Voltage Range(V)			
0A	< 125			
0B	125 to < 250			
1A	250 to < 500			
1B	500 to < 1000			
1C	1000 to < 2000			
2	2000 to < 4000			
3A	4000 to < 8000			
3B	≥ 8000			



## **Applications**

- Portable appliances
- · Battery management

## Absolute Maximum Ratings (at T<sub>a</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	V
Gate-Source Voltage	V <sub>G</sub> s	± 20	V
Drain Current	I <sub>D</sub>	6	А
Peak Drain Current, Pulsed 1)	I <sub>DM</sub>	30	Α
Total Power Dissipation <sup>2)</sup> t ≤ 10 s	P <sub>tot</sub>	2.8	W
Operating Junction and Storage Temperature Range	T <sub>j,</sub> T <sub>stg</sub>	- 55 to + 150	°C

#### **Thermal Characteristics**

Thornial Gridiactorictics				
Parameter	Symbol	Value	Unit	
Thermal Resistance from Junction to Ambient <sup>2)</sup>	t ≤ 10 s Steady State	RθJA	45 80	°C/W

<sup>&</sup>lt;sup>1)</sup> Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.



<sup>&</sup>lt;sup>2)</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.

# Characteristics at T<sub>a</sub>= 25°C unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at I <sub>D</sub> = 250 μA	V <sub>(BR)DSS</sub>	60	-	-	V
Drain-Source Leakage Current at V <sub>DS</sub> = 48 V	I <sub>DSS</sub>	-	-	1	μA
Gate-Source Leakage Current at $V_{GS} = \pm 20 \text{ V}$	Igss	-	-	± 10	μA
Gate-Source Threshold Voltage at $V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	V <sub>GS(th)</sub>	1.2	-	2.5	V
Drain-Source On-State Resistance at $V_{GS}$ = 10 V, $I_D$ = 6 A at $V_{GS}$ = 4.5 V, $I_D$ = 4 A	R <sub>DS(on)</sub>	- -	- -	40 50	mΩ
DYNAMIC PARAMETERS					
Forward Transconductance at $V_{DS}$ = 4.5 V, $I_D$ = 4 A	<b>G</b> FS	-	8.4	-	S
Gate resistance at $V_{DS} = 0 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	Rg	-	0.8	-	Ω
Input Capacitance at $V_{DS} = 30 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	Ciss	-	1087	-	pF
Output Capacitance at $V_{DS}$ = 30 V, $V_{GS}$ = 0 V, f = 1 MHz	Coss	-	47	-	pF
Reverse Transfer Capacitance at $V_{DS}$ = 30 V, $V_{GS}$ = 0 V, f = 1 MHz	Crss	-	43	-	pF
Total Gate Charge at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 4.5 V	Qg	1 1	19 8.6	-	nC
Gate to Source Charge at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V	$Q_{gs}$	1	4.7	-	nC
Gate to Drain Charge at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V	$Q_{gd}$	-	2.6	-	nC
Turn-On Delay Time at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V, $R_G$ = 3.3 $\Omega$	$t_{\sf d(on)}$	ı	10	-	ns
Turn-On Rise Time at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V, $R_G$ = 3.3 $\Omega$	t <sub>r</sub>	ı	21	-	ns
Turn-Off Delay Time at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V, $R_G$ = 3.3 $\Omega$	$t_{\text{d(off)}}$	-	9	-	ns
Turn-Off Fall Time at $V_{DS}$ = 30 V, $I_D$ = 6 A, $V_{GS}$ = 10 V, $R_G$ = 3.3 $\Omega$	t <sub>f</sub>	-	2	-	ns
Body-Diode PARAMETERS					
Drain-Source Diode Forward Voltage at Is = 1 A	V <sub>SD</sub>	-	-	1.2	V
Body-Diode Continuous Current	Is	-	-	6	Α
Body Diode Reverse Recovery Time at Is = 6 A, di/dt = 100 A / µs	t <sub>rr</sub>	-	8.3	-	ns
Body Diode Reverse Recovery Charge at Is = 6 A, di/dt = 100 A / µs	Qrr	-	4.9	-	nC



#### **Electrical Characteristics Curves**

Fig. 1 Typical Output Characteristics

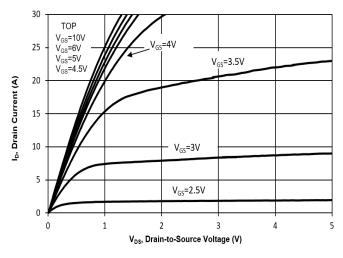


Fig. 2 Typical Transfer Characteristics

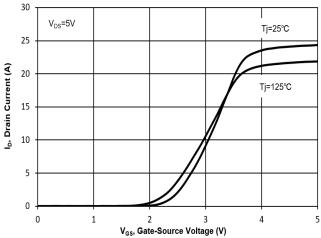


Fig. 3 On-Resistance vs. Drain Current

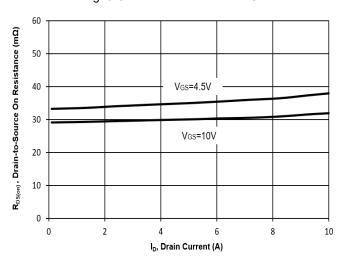


Fig. 4 On-Resistance vs. Gate-Source Voltage

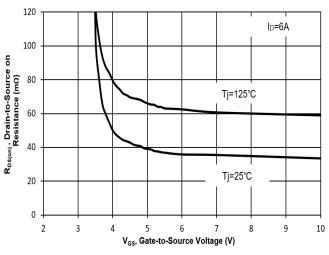


Fig. 5 On-Resistance vs.Tj

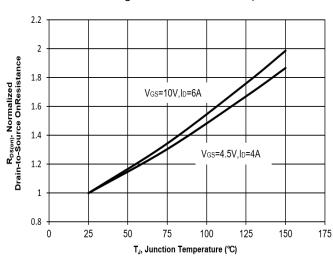
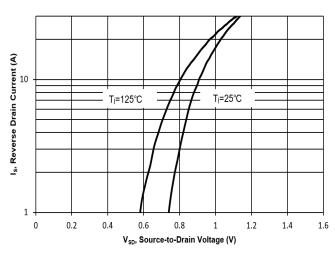


Fig. 6 Typical Body-Diode Forward Characteristics





### **Electrical Characteristics Curves**

Fig. 7 Typical Junction Capacitance

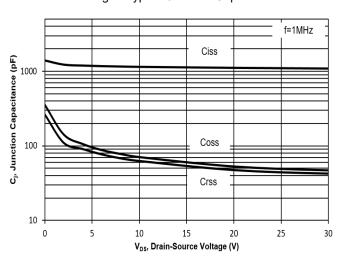


Fig. 8 Drain-Source Leakage Current vs. T<sub>j</sub>

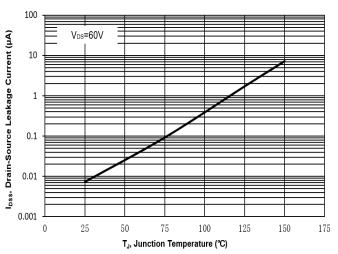


Fig. 9  $V_{(BR)DSS}$  vs. Junction Temperature

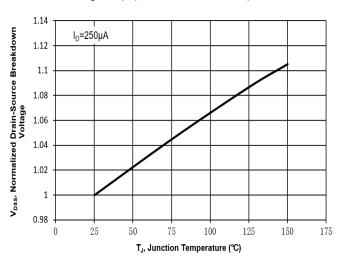


Fig. 10 Gate Threshold Variation vs.  $T_{\rm j}$ 

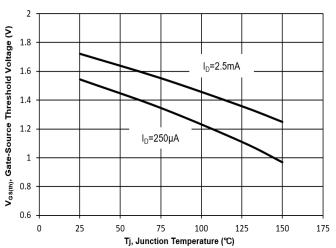
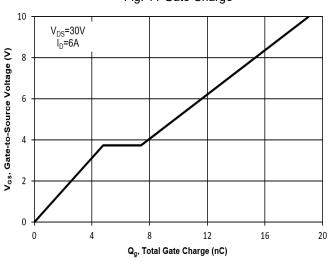
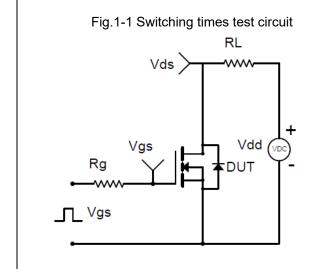


Fig. 11 Gate Charge





## **Test Circuits**



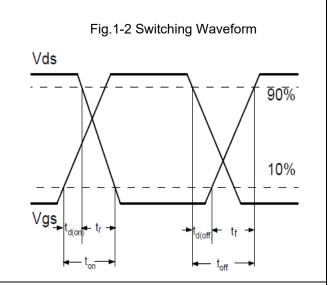


Fig.2-1 Gate charge test circuit

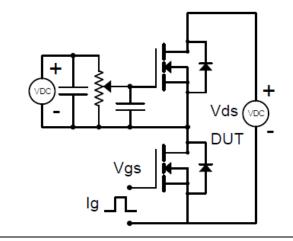
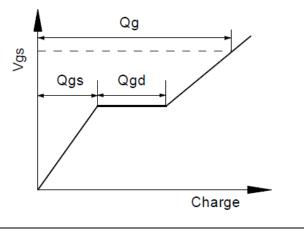


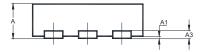
Fig.2-2 Gate charge waveform

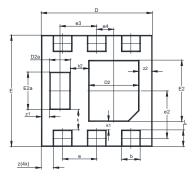




### Package Outline Dimensions (Units: mm)

**DFN2020-6HMA** 

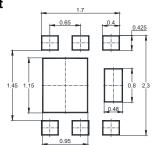




UNIT	Α	A1	A3	b	D	D2	D2a	Е	E2	E2a	L
mm	0.55	0	0.15	0.25	1.95	0.85	0.33	1.95	1.05	0.65	0.225
111111	0.65	0.05	Тур.	0.35	2.05	1.05	0.43	2.05	1.25	0.75	0.325

UNIT	е	e2	e3	e4	k	k1	k2	Z	z1	z2
mm	0.65	0.863	0.7	0.325	0.37	0.15	0.36	0.2	0.11	0.2
mm	BSC	BSC	BSC	BSC	BSC	BSC	BSC	BSC	BSC	BSC

**Recommended Soldering Footprint** 



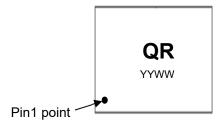
### **Packing information**

	Tape Width	Pitch		Reel Size		D D 10 11 0 11	
Package	(mm)	mm	inch	mm	inch	Per Reel Packing Quantity	
DFN2020-6HMA	8	4 ± 0.1	0.157 ± 0.004	178	7	4,000	

## **Marking information**

- " QR " = Part No.
- " YYWW " = Date Code Marking
- " Y " = Year (ex: 19 = 2019)
- "W" = Week (ex: 09 = the 9th week of the year)

Font type: Arial



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